

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10632793	PARANHOS-BACCALA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Stephen Kapushoc	1634

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated searches, histories enclosed	6/6/08	/STK/
Updated searches, histories enclosed	03/02/2008	/STK/
Interference search of keywords in claims of patent literature	08/24/2009	/STK/
Text limited searches of class 536 subclasses 23.1 and 24.3	08/24/2009	/STK/
STIC interference search of SEQ ID NOs: 2 and 31, results available in SCORE.	08/24/2009	/STK/

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
536	23.1; 24.3	08/31/2009	/STK/

	/Stephen Kapushoc/ Primary Examiner, Art Unit 1634
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